

| | | | |
|-----------------------------------|---------------------------------------|---|-------------|
| Notice of References Cited | Application/Control No. 10/540,472 | Applicant(s)/Patent Under Reexamination FUJIMOTO ET AL. | |
| | Examiner Fred Prince | Art Unit 1724 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|----------------------|----------------|
| * | A | US-1,940,585 | 12-1933 | LORENZ FAUTH PHILIPP | 422/271 |
| * | B | US-5,338,451 | 08-1994 | Lindberg et al. | 210/405 |
| * | C | US-5,632,907 | 05-1997 | Norbury, Fritz | 210/787 |
| * | D | US-5,904,858 | 05-1999 | Turchetti, Attilio | 210/767 |
| * | E | US-6,478,163 | 11-2002 | Otsuka, Takaharu | 210/374 |
| | F | US- | | | |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|-----------------|----------------|
| | N | JP 10-28899 | 02-1998 | Japan | Hibi et al. | |
| | O | JP P2000-350946 | 12-2000 | Japan | Fujimoto et al. | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.